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Accreditation number **SCS 108**
Numero d'accreditamento

SCS Directory Registro SCS

Accreditation Standard ISO/IEC 17025:2005
Norma d'accreditamento ISO/IEC

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Calibration Laboratory for Specific Electric and Magnetic fields and SAR measurements

Measured Quantity Instrument	Range	Condition of measurement	Best Measurement Capability CMC at (22 ± 3) °C	Remarks
Specific absorption rate (SAR) Calibration of dosimetric E-field probes	E* field (typical ¹) 0,5 V/m ... 500 V/m	300 MHz ... 450 MHz	6,7 % (13,3 % for SAR)	e.g. ET3DVx, ES3DVx, EX3DVx, ET1DVx, EU2DVx Temperature transfer calibration *) As example, the indicated range corresponds to 0,2 mW/kg ... 200 W/kg for head tissue simulating liquid and f = 450 MHz
	E* field (typical ¹) 0,45 V/m ... 450 V/m	800 MHz ... 3 GHz	5,5 % (11 % for SAR)	e.g. ET3DVx, ES3DVx, EX3DVx, ET1DVx, EU2DVx Waveguide analytical calibration *) As example, the indicated range corresponds to 0,2 mW/kg ... 200 W/kg for head tissue simulating liquid and f = 1800 MHz
	E* field (typical ¹) 0,4 V/m ... 450 V/m	3 GHz ... 6 GHz	6,5 % (13,1 % for SAR)	e.g. EX3DVx, ET1DVx Waveguide analytical calibration *) As example, the indicated range corresponds to 0,2 mW/kg ... 200 W/kg for head tissue simulating liquid and f = 5200 MHz
Calibration of temperature SAR probes	0 °C ... + 60 °C	Tissue simulating Liquids	0,15 K (5 % temperature gradient for SAR)	As example, the temperature gradient of T1Vx and T1V3LAB probes can be determined to 5 %, which is also contribution to SAR accuracy. (Noise is dominating the lower SAR threshold to typically 0,2 W/kg)



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Calibration Laboratory for Specific Electric and Magnetic fields and SAR measurements

Measured Quantity Instrument	Range	Condition of measurement	Best Measurement Capability CMC at (22 ± 3) °C	Remarks
Calibration of test system validation dipoles	SAR* 1 g and 10 g per 1 W input power	300 MHz ... 450 MHz	18,1 % for SAR 1 g 17,6 % for SAR 10 g	e.g. D835V2 ... D3000V2 according to IEEE 1528-2003, for 1 g and 10 g SAR *) SAR given (as example) for head tissue simulating liquid
		835 MHz ... 3 GHz	17,0 % for SAR 1 g 16,5 % for SAR 10 g	
	SAR* 1 g and 10 g per 1 W input power	3 GHz ... 6 GHz	19,9 % for SAR 1 g 19,5 % for SAR 10 g	e.g. D3500V2 ... D5GHzV2 according to IEC 62209-2, for 1 g and 10 g SAR *) SAR given (as example) for head tissue simulating liquid
Calibration of dipoles in air	E* field per 0,1 W input power 30 V/m ... 300 V/m	800 MHz ... 3 GHz	12,8 % for E field	e.g. CD835V3 ... CD2450V3 according to ANSI PC 63,19 2001, for E field and H field
	H* field per 0,1 W input power 0,07 A/m ... 0,7 A/m		8,2 % for H field	
DC Voltage				
Calibration of readout units for field and SAR probes	2 mV		0,65 %	e.g. DAE3Vx, DAE4Vx, DAEasyVx
	200 mV		0,06 %	

¹ Slightly depending on the frequency and probe type

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Accreditation No.: **SCS 108**

Client **Qualcomm USA**

Certificate No: **ET3-1733_Sep08**

CALIBRATION CERTIFICATE

Object **ET3DV6 - SN:1733**

Calibration procedure(s) **QA CAL-01.v6, QA CAL-12.v5 and QA CAL-23.v3
Calibration procedure for dosimetric E-field probes**

Calibration date: **September 17, 2008**

Condition of the calibrated item **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	1-Apr-08 (No. 217-00788)	Apr-09
Power sensor E4412A	MY41495277	1-Apr-08 (No. 217-00788)	Apr-09
Power sensor E4412A	MY41498087	1-Apr-08 (No. 217-00788)	Apr-09
Reference 3 dB Attenuator	SN: S5054 (3c)	1-Jul-08 (No. 217-00865)	Jul-09
Reference 20 dB Attenuator	SN: S5086 (20b)	31-Mar-08 (No. 217-00787)	Apr-09
Reference 30 dB Attenuator	SN: S5129 (30b)	1-Jul-08 (No. 217-00866)	Jul-09
Reference Probe ES3DV2	SN: 3013	2-Jan-08 (No. ES3-3013_Jan08)	Jan-09
DAE4	SN. 660	9-Sep-08 (No. DAE4-660_Sep08)	Sep-09

Secondary Standards	ID #	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (in house check Oct-07)	In house check: Oct-09
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-07)	In house check: Oct-08

Calibrated by: **Name** Katja Pokovic **Function** Technical Manager

Approved by: **Name** Niels Kuster **Function** Quality Manager

Signature

Issued: September 17, 2008

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Accreditation No.: **SCS 108**

Glossary:

TSL	tissue simulating liquid
NORM _{x,y,z}	sensitivity in free space
ConvF	sensitivity in TSL / NORM _{x,y,z}
DCP	diode compression point
Polarization φ	φ rotation around probe axis
Polarization ϑ	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis

Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}*: Assessed for E-field polarization $\vartheta = 0$ ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide). *NORM_{x,y,z}* are only intermediate values, i.e., the uncertainties of *NORM_{x,y,z}* does not effect the E^2 -field uncertainty inside TSL (see below *ConvF*).
- NORM(f)_{x,y,z} = NORM_{x,y,z} * frequency_response* (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of *ConvF*.
- DCP_{x,y,z}*: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- ConvF and Boundary Effect Parameters*: Assessed in flat phantom using E-field (or Temperature Transfer Standard for $f \leq 800$ MHz) and inside waveguide using analytical field distributions based on power measurements for $f > 800$ MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to *NORM_{x,y,z} * ConvF* whereby the uncertainty corresponds to that given for *ConvF*. A frequency dependent *ConvF* is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- Spherical isotropy (3D deviation from isotropy)*: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset*: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

ET3DV6 SN:1733

September 17, 2008

Probe ET3DV6

SN:1733

Manufactured:	September 27, 2002
Last calibrated:	September 4, 2007
Recalibrated:	September 17, 2008

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

ET3DV6 SN:1733

September 17, 2008

DASY - Parameters of Probe: ET3DV6 SN:1733

Sensitivity in Free Space^A

Diode Compression^B

NormX	1.55 ± 10.1%	$\mu\text{V}/(\text{V}/\text{m})^2$	DCP X	93 mV
NormY	1.49 ± 10.1%	$\mu\text{V}/(\text{V}/\text{m})^2$	DCP Y	94 mV
NormZ	1.61 ± 10.1%	$\mu\text{V}/(\text{V}/\text{m})^2$	DCP Z	92 mV

Sensitivity in Tissue Simulating Liquid (Conversion Factors)

Please see Page 8.

Boundary Effect

TSL 900 MHz Typical SAR gradient: 5 % per mm

Sensor Center to Phantom Surface Distance		3.7 mm	4.7 mm
SAR _{be} [%]	Without Correction Algorithm	9.5	5.7
SAR _{be} [%]	With Correction Algorithm	0.8	0.5

TSL 1750 MHz Typical SAR gradient: 10 % per mm

Sensor Center to Phantom Surface Distance		3.7 mm	4.7 mm
SAR _{be} [%]	Without Correction Algorithm	11.1	7.2
SAR _{be} [%]	With Correction Algorithm	0.7	0.4

Sensor Offset

Probe Tip to Sensor Center 2.7 mm

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A The uncertainties of NormX,Y,Z do not affect the E²-field uncertainty inside TSL (see Page 8).

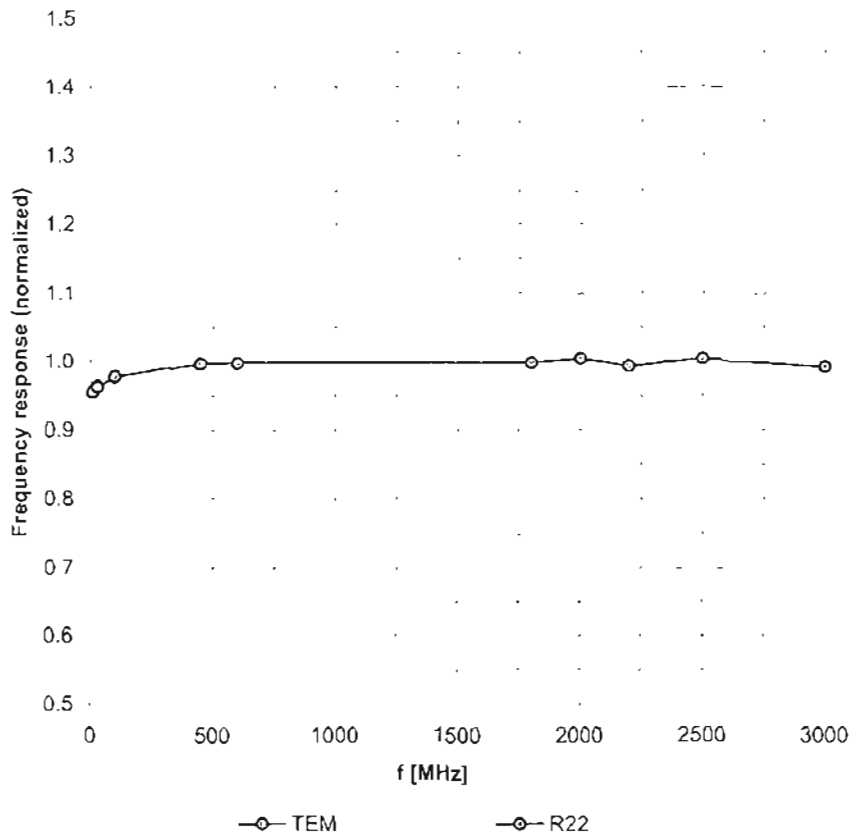
^B Numerical linearization parameter: uncertainty not required

ET3DV6 SN:1733

September 17, 2008

Frequency Response of E-Field

(TEM-Cell:ifi110 EXX, Waveguide: R22)

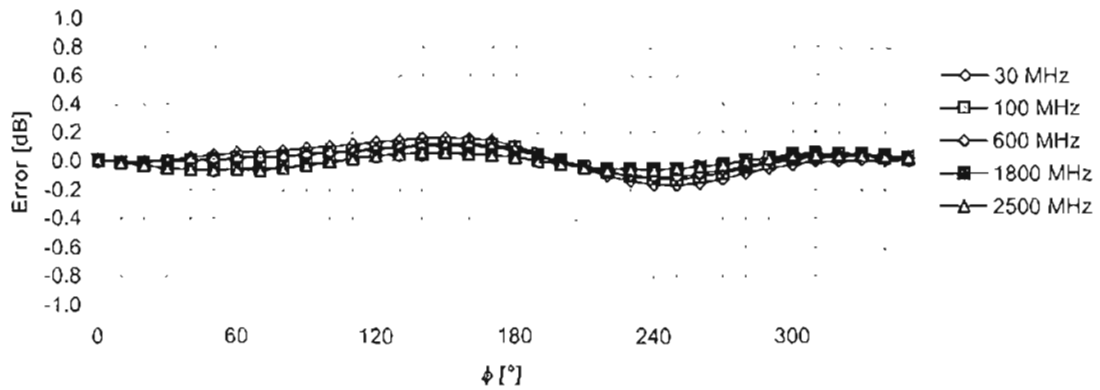
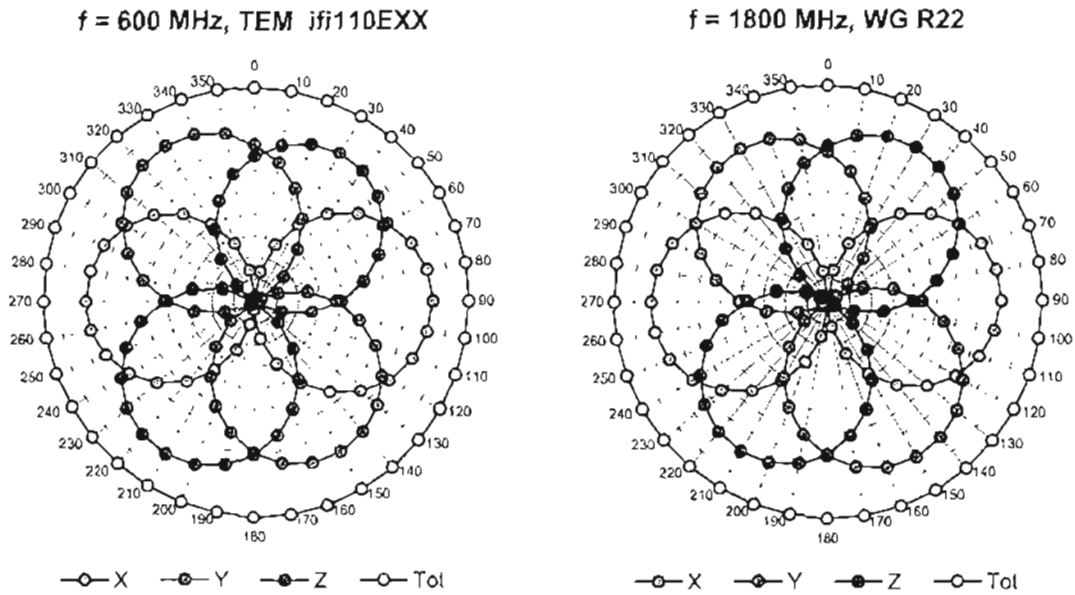


Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ (k=2)

ET3DV6 SN:1733

September 17, 2008

Receiving Pattern (ϕ), $\vartheta = 0^\circ$

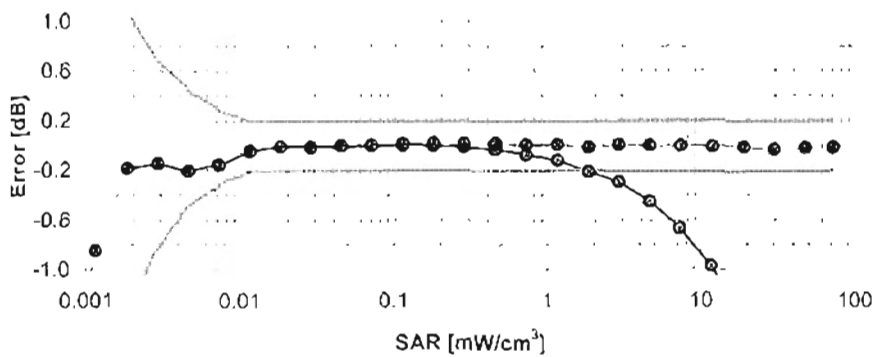
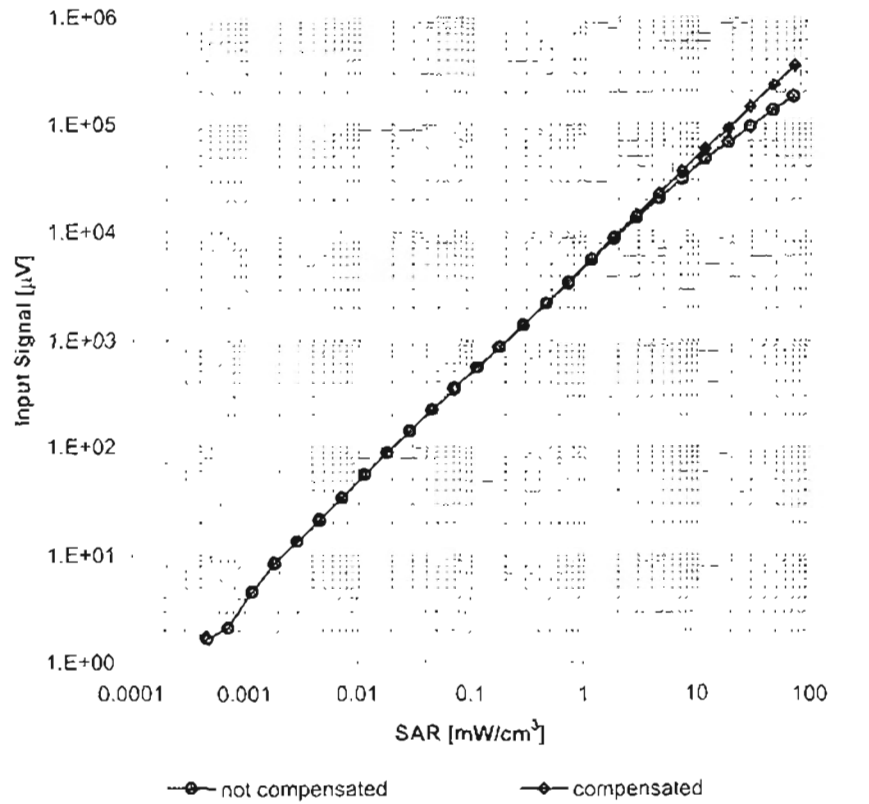


Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ (k=2)

ET3DV6 SN:1733

September 17, 2008

Dynamic Range $f(\text{SAR}_{\text{head}})$ (Waveguide R22, $f = 1800 \text{ MHz}$)

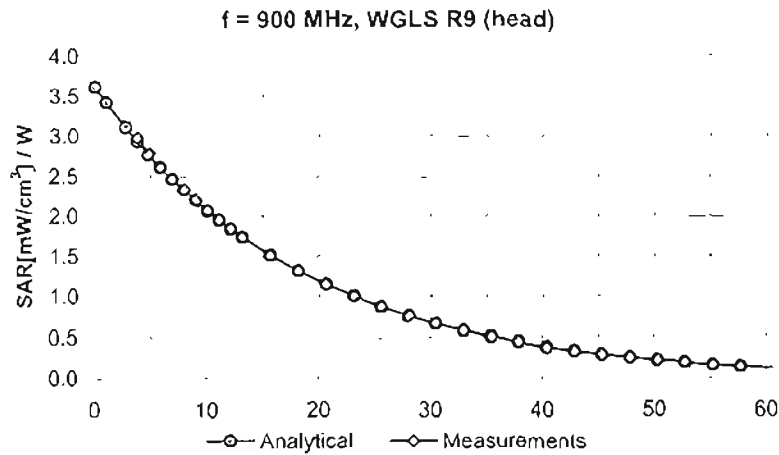


Uncertainty of Linearity Assessment: $\pm 0.6\%$ ($k=2$)

ET3DV6 SN:1733

September 17, 2008

Conversion Factor Assessment



f [MHz]	Validity [MHz] ^c	TSL	Permittivity	Conductivity	Alpha	Depth	ConvF Uncertainty
450	± 50 / ± 100	Head	43.5 ± 5%	0.87 ± 5%	0.35	1.83	7.79 ± 13.3% (k=2)
835	± 50 / ± 100	Head	41.5 ± 5%	0.90 ± 5%	0.23	3.32	6.67 ± 11.0% (k=2)
900	± 50 / ± 100	Head	41.5 ± 5%	0.97 ± 5%	0.23	3.29	6.46 ± 11.0% (k=2)
1640	± 50 / ± 100	Head	40.3 ± 5%	1.29 ± 5%	0.70	2.13	5.57 ± 11.0% (k=2)
1750	± 50 / ± 100	Head	40.1 ± 5%	1.37 ± 5%	0.87	1.86	5.45 ± 11.0% (k=2)
1900	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.99	1.63	5.21 ± 11.0% (k=2)
1950	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.99	1.67	5.06 ± 11.0% (k=2)
2450	± 50 / ± 100	Head	39.2 ± 5%	1.80 ± 5%	0.99	1.40	4.55 ± 11.0% (k=2)
450	± 50 / ± 100	Body	56.7 ± 5%	0.94 ± 5%	0.27	1.78	8.16 ± 13.3% (k=2)
835	± 50 / ± 100	Body	55.2 ± 5%	0.97 ± 5%	0.25	3.22	6.41 ± 11.0% (k=2)
900	± 50 / ± 100	Body	55.0 ± 5%	1.05 ± 5%	0.30	2.92	6.25 ± 11.0% (k=2)
1640	± 50 / ± 100	Body	53.8 ± 5%	1.40 ± 5%	0.95	2.03	5.07 ± 11.0% (k=2)
1750	± 50 / ± 100	Body	53.4 ± 5%	1.49 ± 5%	0.99	1.81	4.73 ± 11.0% (k=2)
1900	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.99	1.73	4.47 ± 11.0% (k=2)
1950	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.99	1.76	4.56 ± 11.0% (k=2)
2450	± 50 / ± 100	Body	52.7 ± 5%	1.95 ± 5%	0.93	1.60	3.84 ± 11.0% (k=2)

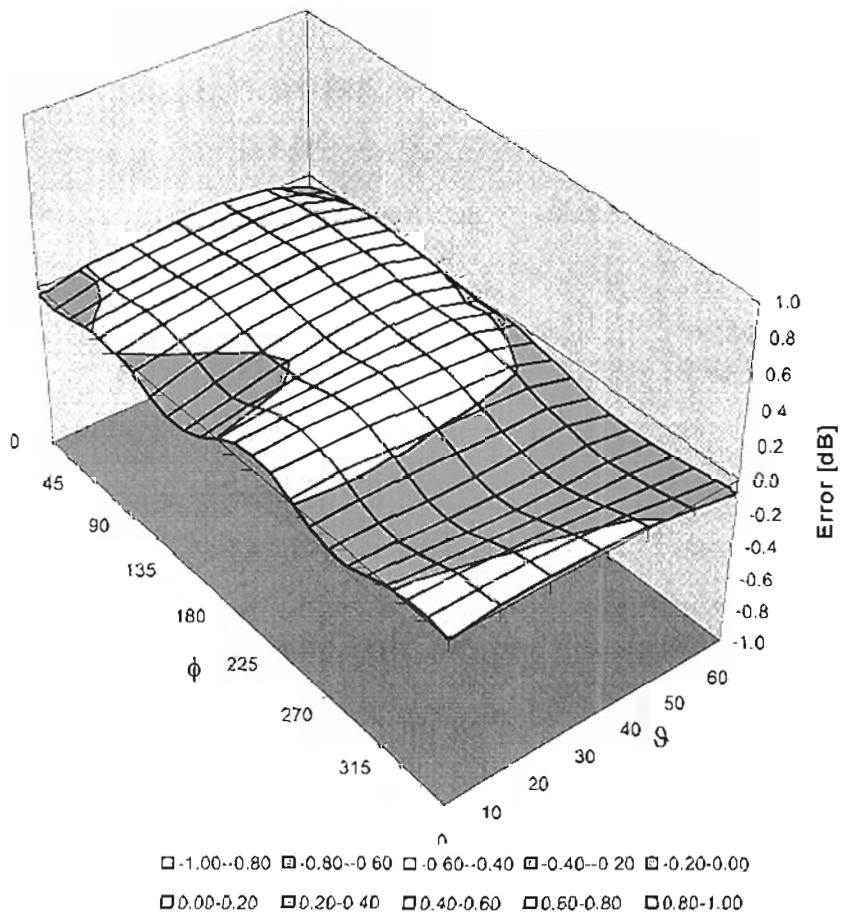
^c The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

ET3DV6 SN:1733

September 17, 2008

Deviation from Isotropy in HSL

Error (ϕ , ϑ), $f = 900$ MHz



Uncertainty of Spherical Isotropy Assessment: $\pm 2.6\%$ ($k=2$)

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Accreditation No.: **SCS 108**

Client **Kyocera USA**

Certificate No: **D1900V2-5d016-Sep08**

CALIBRATION CERTIFICATE

Object **D1900V2 - SN: 5d016**

Calibration procedure(s) **QA CAL-05.v7
Calibration procedure for dipole validation kits**

Calibration date: **September 15, 2008**

Condition of the calibrated item **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	04-Oct-07 (No. 217-00736)	Oct-08
Power sensor HP 8481A	US37292783	04-Oct-07 (No. 217-00736)	Oct-08
Reference 20 dB Attenuator	SN: 5086 (20g)	01-Jul-08 (No. 217-00864)	Jul-09
Type-N mismatch combination	SN: 5047.2 / 06327	01-Jul-08 (No. 217-00867)	Jul-09
Reference Probe ES3DV2	SN: 3025	28-Apr-08 (No. ES3-3025_Apr08)	Apr-09
DAE4	SN: 601	14-Mar-08 (No. DAE4-601_Mar08)	Mar-09
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power sensor HP 8481A	MY41092317	18-Oct-02 (in house check Oct-07)	In house check: Oct-09
RF generator R&S SMT-06	100005	4-Aug-99 (in house check Oct-07)	In house check: Oct-09
Network Analyzer HP 8753E	US37390585 S4206	18-Oct-01 (in house check Oct-07)	In house check: Oct-08

	Name	Function	Signature
Calibrated by:	Jeton Kastrati	Laboratory Technician	
Approved by:	Katja Pokovic	Technical Manager	

Issued: September 17, 2008

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Accreditation No.: **SCS 108**

Glossary:

TSL	tissue simulating liquid
ConvF	sensitivity in TSL / NORM x,y,z
N/A	not applicable or not measured

Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- CENELEC EN 50361, "Basic standard for the measurement of Specific Absorption Rate related to human exposure to electromagnetic fields from mobile phones (300 MHz - 3 GHz), July 2001
- Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

- DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions:** Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL:** The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss:** These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay:** One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured:** SAR measured at the stated antenna input power.
- SAR normalized:** SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters:** The measured TSL parameters are used to calculate the nominal SAR result.

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V5.0
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V5.0	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	1900 MHz \pm 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	40.0	1.40 mho/m
Measured Head TSL parameters	(22.0 \pm 0.2) °C	40.7 \pm 6 %	1.47 mho/m \pm 6 %
Head TSL temperature during test	(21.5 \pm 0.2) °C	----	----

SAR result with Head TSL

SAR averaged over 1 cm³ (1 g) of Head TSL	condition	
SAR measured	250 mW input power	10.3 mW / g
SAR normalized	normalized to 1W	41.2 mW / g
SAR for nominal Head TSL parameters ¹	normalized to 1W	40.6 mW / g \pm 17.0 % (k=2)

SAR averaged over 10 cm³ (10 g) of Head TSL	Condition	
SAR measured	250 mW input power	5.37 mW / g
SAR normalized	normalized to 1W	21.5 mW / g
SAR for nominal Head TSL parameters ¹	normalized to 1W	21.4 mW / g \pm 16.5 % (k=2)

¹ Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"